

Chipsmall Limited consists of a professional team with an average of over 10 year of expertise in the distribution of electronic components. Based in Hongkong, we have already established firm and mutual-benefit business relationships with customers from, Europe, America and south Asia, supplying obsolete and hard-to-find components to meet their specific needs.

With the principle of "Quality Parts, Customers Priority, Honest Operation, and Considerate Service", our business mainly focus on the distribution of electronic components. Line cards we deal with include Microchip, ALPS, ROHM, Xilinx, Pulse, ON, Everlight and Freescale. Main products comprise IC, Modules, Potentiometer, IC Socket, Relay, Connector. Our parts cover such applications as commercial, industrial, and automotives areas.

We are looking forward to setting up business relationship with you and hope to provide you with the best service and solution. Let us make a better world for our industry!



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Transistor Testers

520C



Model 520C

Industrial Transistor Tester

The B+K Precision model 520C Transistor
Tester is designed for in-circuit and out-of
circuit transistor testing with special features for
making additional tests on devices out-of circuit.
The instrument is designed for a minimum amount of
control manipulation, making for rapid testing of most devices.

- ■Determines good or bad transistors, FET's, SCR's, or diodes.
- Patented limited-energy pulse circuit permits in-circuit testing in the presence of low shunt impedance's with complete safety for the device under test.
- Easy to operate panel eliminates the need to refer to a reference or operating manual-only three switches, no panel adjustments.
- ■Six position test switch makes it unnecessary to know the device terminal identification.
- A LED array identifies leakage in both Silicon and Germanium devices.
- Front Panel socket for out-of –circuit transistor testing.

Model 510A

Portable Transistor Tester

The model 5 I OA performs Good/Bad test for transistors, FET's, and SCR's. It also identifies NPN or PNP for transistors, N-channel or P-channel for FET, FET-gate lead, all leads of transistors in LO drive, base lead in HI drive, and all leads of SCR. It uses a patented limited-energy pulse circuit, which provides highly successful in-circuit testing in the presence of low shunt

impedance's with complete safety for the device under test. The instrument is designed for a minimum amount of control manipulation, allowing for rapid test-

510A ing of most devices.

- ■Rapid In-circuit and out-of circuit testing
- ■Good/Bad test
- ■NPN or PNP identification for transistors
- ■N-channel or P-channel identification for FET
- ■FET-gate and SCR lead identification
- ■Battery operated (4 x 1.5 AA batteries)

Specif	ications	models
	520C	510A
IN-CIRCUIT TES		100
GOOD/BAD TEST	PNP and NPN transisto	arc
GOOD/BAD ILSI	FET's, SCR's	
IDENTIFIES	NPN or PNP	NPN or PNP
	FET as N-channel or P-channel	FET as N-channel or
	TET as iv-channel of 1-channel	P-channel
	Silicone or germanium transistors	FET-gate lead, all leads of
	transistors in LO drive, base lead	TET-Sate lead, all leads of
	in HI drive all leads of SCR	
OUT-OF-CIRCUI	T TEST	
GOOD/BAD TEST	PNP and NPN transistors	PNP and NPN transistors
	FET's, SCR's	FET's
IDENTIFIES	NPN or PNP	NPN or PNP
	FET as N-channel or P-channel	FET as N-channel or
	Silicone or germanium transistors	P-channel
MEASURES	Reverse leakage	Does not apply
	from 0.1 mA to 9mA	
ALITOMATIC IN	DICATORS	
AUTOMATIC IN	GOOD	Description by
AUDIBLE TONE LED		Does not apply
TEST SWITCH	NPN or PNP, Ge or Si	NPN or PNP, Ge or Si Base or Gate for good
IEST SWITCH	Base or Gate for good transistor or FET's	transistor or FET's
METER SCALES	Readable from 0.1µA to 9mA	Does not apply
	for Ice leakage, calibrated for silicon	Does not apply
	and germanium power and signal	
	transistor leakage limits	
	transistor rearage initis	
APPLIED TEST (
BASE DRIVE*	250mA (HI), 1mA (LO)	
COLLECTOR*	125mA	
TEST REPETITION	10Hz	5Hz
IN CIDCUIT CUI	INT LIMIT FOR VALID COOP /BA	D. TECT
RESISTANCE	JNT LIMIT FOR VALID GOOD/BA $> 10\Omega$ (HI), 1.5k Ω (LO	
CAPACITANCE	>1022 (HI), 1.3K22 (EC	<u>'</u>
CAFACITANCE	► 13IIIF (III), U.3IIIF (LU)	<25mF (HI), 0.3µF (LO)
GENERAL		
POWER	9V Battery (Supplied)	6VDC from
REQUIREMENT	or optional AC adaptor	4 "AA" batteries
		(not supplied)
OPERATING TEMP	32° to 104°F (0° to 40°C), <75% RH	
DIMENSIONS	7.5 x 4.0 x 2.0"	
(HxWxD)	(191 x 102 x 51 mm)	
WEIGHT	I lb. (450g)	

Accessories

One Year Warranty

SUPPLIED: FP-6 Semiconductor Test Leads (three test leads w/mini-lock clips), Instruction manual, Battery (520C only)
Optional: BE 12 AC adaptor(9VDC)

* Duty Cycle @8% for 520C, 2% for 510A

